

<b>Search Notes</b> 	<b>Application/Control No.</b> 09/813,907	<b>Applicant(s)/Patent under Reexamination</b> ZHANG ET AL.
<b>Examiner</b> Alain L. Bashore	<b>Art Unit</b> 1762	

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
705	35,37	5/13/2006	AB